# MOSFET – Power, N-Channel, DPAK/IPAK 68 A, 30 V

#### Features

- Ultra Low R<sub>DS(on)</sub>
- Higher Efficiency Extending Battery Life
- Logic Level Gate Drive
- Diode Exhibits High Speed, Soft Recovery
- Avalanche Energy Specified
- I<sub>DSS</sub> Specified at Elevated Temperature
- DPAK Mounting Information Provided
- These Devices are Pb-Free and are RoHS Compliant

#### Applications

- DC-DC Converters
- Low Voltage Motor Control
- Power Management in Portable and Battery Powered Products: i.e., Computers, Printers, Cellular and Cordless Telephones, and PCMCIA Cards

#### **MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit		
Drain-to-Source Voltage	V <sub>DSS</sub>	30	Vdc		
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	±20	Vdc		
Thermal Resistance – Junction–to–Case Total Power Dissipation @ $T_C = 25^{\circ}C$ Continuous Drain Current @ $T_C = 25^{\circ}C$ (Note 4) Continuous Drain Current @ $T_C = 100^{\circ}C$	R <sub>θJC</sub> P <sub>D</sub> I <sub>D</sub> I <sub>D</sub>	1.65 75 68 43	°C/W W A A		
Thermal Resistance – Junction–to–Ambient (Note 2) Total Power Dissipation @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 100^{\circ}C$ Pulsed Drain Current (Note 3)	R <sub>θJA</sub> P <sub>D</sub> I <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	67 1.87 11.3 7.1 36	°C/W W A A A		
Thermal Resistance – Junction–to–Ambient (Note 1) Total Power Dissipation @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 100^{\circ}C$ Pulsed Drain Current (Note 3)	R <sub>θJA</sub> Pd Id Id IdM	120 1.04 8.4 5.3 28	°C/W W A A A		
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	–55 to 150	°C		
Single Pulse Drain-to-Source Avalanche Energy – Starting T <sub>J</sub> = 25°C (V <sub>DD</sub> = 30 Vdc, V <sub>GS</sub> = 10 Vdc, Peak I <sub>L</sub> = 17 Apk, L = 5.0 mH, R <sub>G</sub> = 25 $\Omega$ )	E <sub>AS</sub>	722	mJ		
Maximum Lead Temperature for Soldering Purposes, 1/8 in from case for 10 seconds	ΤL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

 When surface mounted to an FR4 board using the minimum recommended pad size.

pad size. 2. When surface mounted to an FR4 board using 0.5 sq. in. drain pad size.

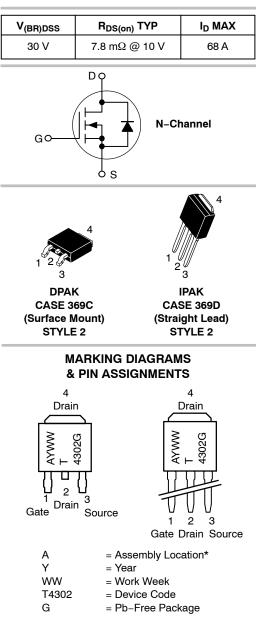
3. Pulse Test: Pulse Width = 300  $\mu$ s, Duty Cycle = 2%.

4. Current Limited by Internal Lead Wires.



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\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain–Source Breakdown Voltage $(V_{GS} = 0 \text{ Vdc}, I_D = 250 \ \mu\text{A})$ Positive Temperature Coefficient		V <sub>(BR)DSS</sub>	30 -	_ 25		Vdc mV/°C
Zero Gate Voltage Drain Current ( $V_{GS} = 0$ Vdc, $V_{DS} = 30$ Vdc, T ( $V_{GS} = 0$ Vdc, $V_{DS} = 30$ Vdc, T		I <sub>DSS</sub>			1.0 10	μAdc
Gate-Body Leakage Current (VG	<sub>S</sub> = ±20 Vdc, V <sub>DS</sub> = 0 Vdc)	I <sub>GSS</sub>	-	_	±100	nAdc
ON CHARACTERISTICS						•
Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μAdc) Negative Temperature Coefficien	t	V <sub>GS(th)</sub>	1.0 _	1.9 -3.8	3.0 _	Vdc
Static Drain–Source On–State Resistance $(V_{GS} = 10 \text{ Vdc}, I_D = 20 \text{ Adc})$ $(V_{GS} = 10 \text{ Vdc}, I_D = 10 \text{ Adc})$ $(V_{GS} = 4.5 \text{ Vdc}, I_D = 5.0 \text{ Adc})$		R <sub>DS(on)</sub>		0.0078 0.0078 0.010	0.010 0.010 0.013	Ω
Forward Transconductance (V <sub>DS</sub>	= 15 Vdc, I <sub>D</sub> = 10 Adc)	gFS	-	20	-	Mhos
OYNAMIC CHARACTERISTICS						
Input Capacitance		C <sub>iss</sub>	-	2050	2400	pF
Output Capacitance	$(V_{DS} = 24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C <sub>oss</sub>	-	640	800	_
Reverse Transfer Capacitance		C <sub>rss</sub>	-	225	310	
SWITCHING CHARACTERISTICS	(Note 6)					
Turn-On Delay Time		t <sub>d(on)</sub>	-	11	20	ns
Rise Time	(V <sub>DD</sub> = 25 Vdc, I <sub>D</sub> = 1.0 Adc, V <sub>GS</sub> = 10 Vdc,	t <sub>r</sub>	-	15	25	
Turn-Off Delay Time	$R_{G} = 6.0 \Omega$	t <sub>d(off)</sub>	-	85	130	
Fall Time	а ,	t <sub>f</sub>	-	55	90	
Turn-On Delay Time		t <sub>d(on)</sub>	-	11	20	ns
Rise Time	$(V_{DD} = 25 \text{ Vdc}, I_D = 1.0 \text{ Adc},$	t <sub>r</sub>	-	13	20	
Turn-Off Delay Time	V <sub>GS</sub> = 10 Vdc, R <sub>G</sub> = 2.5 Ω)	t <sub>d(off)</sub>	-	55	90	
Fall Time	,	t <sub>f</sub>	-	40	75	]
Turn-On Delay Time		t <sub>d(on)</sub>	-	15	-	ns
Rise Time	$(V_{DD} = 24 \text{ Vdc}, I_D = 20 \text{ Adc},$	t <sub>r</sub>	-	25	-	
Turn-Off Delay Time	V <sub>GS</sub> = 10 Vdc, R <sub>G</sub> = 2.5 Ω)	t <sub>d(off)</sub>	-	40	-	
Fall Time		t <sub>f</sub>	-	58	-	
Gate Charge		Q <sub>T</sub>	-	55	80	nC
$(V_{DS} = 24 \text{ Vdc}, I_{D} = 2.0 \text{ Adc},$		Q <sub>gs</sub> (Q1)	-	5.5	-	1
	V <sub>GS</sub> = 10 Vdc)	Q <sub>gd</sub> (Q2)	-	15	-	
BODY-DRAIN DIODE RATINGS (	Note 5)					
Diode Forward On-Voltage ( $I_S = 2.3 \text{ Adc}, V_{GS} = 0 \text{ Vdc}$ )		V <sub>SD</sub>	_	0.75	1.0	Vdc

Didue i diwalu Oli-Vollaye	vsD				vuc	
(I <sub>S</sub> = 2.3 Adc, V <sub>GS</sub> = 0 Vdc)		-	0.75	1.0		
(I <sub>S</sub> = 20 Adc, V <sub>GS</sub> = 0 Vdc)		-	0.90	-		
(I_S = 2.3 Adc, V_{GS} = 0 Vdc, T_J =		-	0.65	-		
Reverse Recovery Time			-	39	65	ns
	(I <sub>S</sub> = 2.3 Adc, V <sub>GS</sub> = 0 Vdc, dI <sub>S</sub> /dt = 100 A/μs)	t <sub>a</sub>	-	20	-	
		t <sub>b</sub>	-	19	-	
Reverse Recovery Stored Charge		Q <sub>rr</sub>	-	0.043	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Indicates Pulse Test: Pulse Width =  $300 \ \mu sec \ max$ , Duty Cycle  $\leq 2\%$ . 6. Switching characteristics are independent of operating junction temperature.

#### 50 60 $V_{GS} = 4 V$ $T_J = 25^{\circ}C$ $V_{DS} > = 10 V$ ID, DRAIN CURRENT (AMPS) ID, DRAIN CURRENT (AMPS) 50 V<sub>GS</sub> = 3.8 V 40 V<sub>GS</sub> = 4.4 V 40 V<sub>GS</sub> = 4.6 V 30 $V_{GS} = 5 V$ 30 $T_J = 25^{\circ}C$ V<sub>GS</sub> = 7 V V<sub>GS</sub> = 3.4 V 20 $T_J = 100^{\circ}C$ 20 /<sub>GS</sub> = 10 V V<sub>GS</sub> = 3.2 V 10 $T_{J} = -55^{\circ}C$ V<sub>GS</sub> = 2.8 V V<sub>GS</sub> = 3.0 V 10 0 0 0 0.5 1.5 2 2.5 3 2 3 5 6 4 V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V) V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Figure 1. On-Region Characteristics **Figure 2. Transfer Characteristics** $I_{\rm D} = 10 \, {\rm A}$ T<sub>J</sub> = 25°C V<sub>GS</sub> = 4.5 V V<sub>GS</sub> = 10 V 0.00E+00 2 4 6 8 0 10 1.00E+01 2.00E+01 3.00E+01 4.00E+01 5.00E+01 6.00E+01 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) ID, DRAIN CURRENT (AMPS) Figure 3. On-Resistance vs. Figure 4. On-Resistance vs. Drain Current Gate-To-Source Voltage and Gate Voltage 10000 l<sub>D</sub> = 18.5 A $V_{GS} = 0 V$ V<sub>GS</sub> = 10 V IDSS, LEAKAGE (nA) 11 11 T<sub>.1</sub> = 150°C $T_J = 100^{\circ}C$ 1 -50 -25 0 25 50 75 100 125 150 5 10 15 20 25 30

#### **TYPICAL CHARACTERISTICS**

Figure 5. On–Resistance Variation with Temperature

TJ, JUNCTION TEMPERATURE (°C)

Figure 6. Drain-To-Source Leakage Current vs. Voltage

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

#### **TYPICAL CHARACTERISTICS**

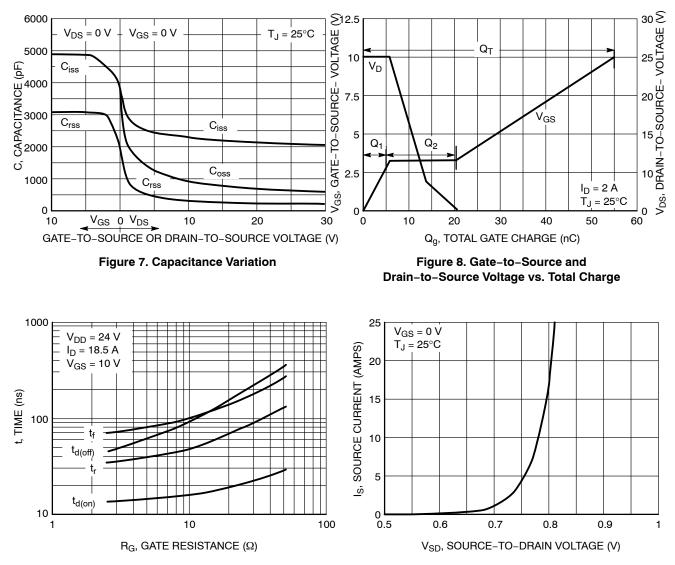
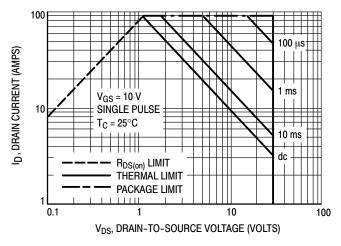


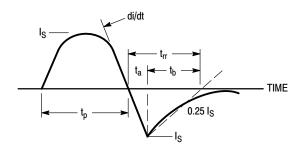
Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

#### **TYPICAL CHARACTERISTICS**









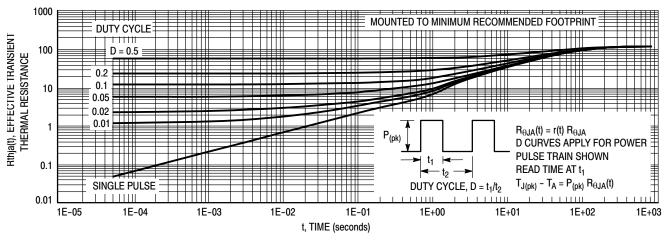


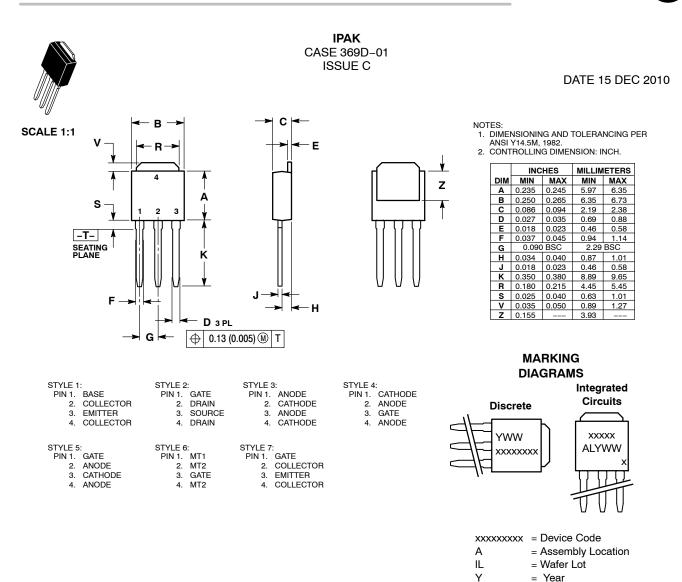
Figure 13. Thermal Response – Various Duty Cycles

#### **ORDERING INFORMATION**

Device	Package Type	Package	Shipping <sup>†</sup>
NTD4302G	DPAK	369C (Pb-Free)	75 Units / Rail
NTD4302-1G	IPAK	369D (Pb-Free)	75 Units / Rail
NTD4302T4G	DPAK	369C (Pb-Free)	2500 Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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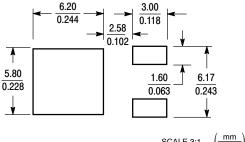
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\*For additional information on our Pb-Free strategy and soldering

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Inches

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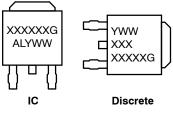
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  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0.006 INCHES PER SIDE 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM

	INC	HES	MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
p	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
c	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	8 REF 2.74 REF		REF
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Ζ	0.155		3.93	

# **MARKING DIAGRAM\***



= Device Code = Assembly Location L = Wafer Lot Y = Year = Work Week WW G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

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